

10/587796

AP20 Recd 31 JUL 2006

UNITED STATES PATENT AND TRADEMARK OFFICE

Examiner:.

Group:

Attorney Docket # 3761

Applicant(s): NIEM, W., ET AL

Serial No.:

Filed:

For : SECURITY SYSTEM AND METHOD FOR  
OPERATING IT

**INFORMATION DISCLOSURE STATEMENT**

July 31, 2006

Honorable Commissioner for Patents  
P. O. Box 1450  
Alexandria, VA 22313-1450

S I R S:

X  In accordance with the Duty of Disclosure, Applicant(s) submit(s) herewith a copy of Foreign Search Report in a counterpart application and copies of the reference(s) indicated therein.

X  In the event that the Foreign Search Report is in a foreign language, a translation thereof is herewith submitted.

X  Attached hereto is a FORM PTO 1449 listing the references.

X  Attached hereto is a copy of a reference cited in the specification of the application as filed. The specification itself recites the relevance of these documents, and pursuant to M.P.E.P. Section 609 A (3) this represents an acceptable Statement of Relevancy. The reference(s) appear(s) at the following page(s) and line(s) of the specification: page 1 lines 24-27, page 2 lines 1-15.

Applicant petitions for consideration of this Information Disclosure Statement since it is being submitted after receipt of an office action. It is respectfully requested that the required fee be charged to the account of the undersigned: 19-4675.

10/587796

AP20 Rec'd PCT/PTO 31 JUL 2006

page 2 of 2

- \_\_\_ Attached hereto are copies of references cited which may be pertinent to this application. Since the references are in the English language, no statement of relevancy is submitted.
- \_\_\_ Attached hereto is a copy of the Office Action issued in the corresponding German application, together with a translation thereof and copies of the references cited therein. A list of the cited references is also attached.
- \_\_\_ Attached hereto copies of references cited which may be pertinent to this application. An English translation of the reference is also attached.
- \_\_\_ Attached hereto is a Statement of Relevancy and copies of references cited therein.
- \_\_\_ Relevancy is indicated either in the English language abstract or an English language equivalent submitted herewith.

Respectfully submitted,



Michael J. Striker  
Attorney for Applicant(s)  
Reg. No. 27233

# **INFORMATION DISCLOSURE CITATION**

(Use several sheets if necessary)

ATTY DOCKET NO.

3761

APPLICATION NO.

APPLICANT(S)

NIEM, W., ET AL

10/587796

FILING DATE

GROUP ART UNIT

AP20 Rec'd PCT/PTO 31 JUL 2006

## **U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	5 548 659	08/20/1996	OKAMOTO			
	6 711 279	03/23/2004	HAMZA ET AL			

## **U.S. PATENT APPLICATION PUBLICATIONS**

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

## **FOREIGN PATENT DOCUMENTS**

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	0 701 232	03/13/1996	EP			✓	

## **OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

		AHMED ELGAMMAL ET AL: "NON-PARAMETRIC MODEL FOR BACKGROUND..." FRAME-RATE WORKSHOP, 1999, PP. 1-17 (IN ENGLISH)
		K. TOYAMA ET AL: "WALLFLOWER: PRINCIPLES AND PRACTICE..." IEEE, 1999. (IN ENGLISH).

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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(Use several sheets if necessary)

Docket Number (Optional)

3761

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Filing Date

Group Art Unit

\*EXAMINER  
INITIAL

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

A. ELGAMMAL ET AL: "BACKGROUND AND FOREGROUND... PROCEEDINGS OF THE IEEE VOL. 90 NO. 7, JULY 2002, PP. 1151-1163 (IN ENGLISH).

M MEYER ET AL: "A NEW SYSTEM FOR VIDEO-BASED DETECTION..." PROCEEDINGS OF IEEE INTERN. CONFERENCE ON SECURITY TECHNOLOGY, LEXINGTON, USA, 1996, PP. 105-106 (IN ENGLISH).

T. AACH ET AL: "CHANGE DETECTION IN IMAGE..." PROCEEDINGS INTERN. WORKSHOP ON INTELLIGENT SIGNAL PROCESSING AND COMMUNICATION SYSTEMS, SENDAI, JAPAN, OCT. 1993, PP. 56-61 (IN ENGLISH).

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DATE CONSIDERED

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